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Cite this: RSC Adv., 2019, 9, 34827

SF₆ abatement in a packed bed plasma reactor: study towards the effect of O₂ concentration†

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SF₆ is a greenhouse gas with extremely high global warming potential value (GWP). In this paper, oxygen and a packed bed plasma reactor (PBR) were applied to remove it. The synergistic effect between oxygen and PBRs was evaluated by the destruction and removal efficiency (DRE) and energy yield (EY) at different oxygen concentrations. The results show that excessive oxygen weakened the micro-discharge in a PBR to suppress SF₆ degradation while the addition of a proper amount of oxygen (1–4%) can improve the DRE and EY. 2% O₂ in the system had the best promoting effect on the destruction of 6–10% SF₆, which made the maximum energy yield (EY) increase by 50.99% to 37.99 g kW⁻¹ h⁻¹ (SF₆ concentration was 10%, flow rate was 150 mL min⁻¹). Moreover, in the flow rate range of 100 mL min⁻¹ to 250 mL min⁻¹, the DRE decreased and the EY increased with the flow rate. In addition, the selectivity of different products were affected by the oxygen concentration. For 6% SF₆, SO₂F₂ selectivity was always the highest while SO₂ was always the lowest; when the oxygen concentration did not exceed 2%, SOF₂ selectivity was higher than SOF₄, otherwise, SOF₄ selectivity was higher than SOF₂. This paper provided experimental support for better understanding of the effect of additional gas concentration on SF₆ decomposition in a PBR.

Received 21st July 2019 Accepted 10th October 2019

DOI: 10.1039/c9ra05629g

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1 Introduction

 SF_6 is widely used in the power industry as an excellent insulating gas, but due to its extremely high global warming potential value (GWP), it is also listed as one of the six restricted gases by the Kyoto Protocol.¹ However, it is still used in large quantities because there is no reliable SF_6 replacement gas.²-⁴ It is estimated that the current global SF_6 usage is above 10 000 tons, and more than 80% is used in the power industry.⁵ Every year, the power industry is facing the problem of recycling and emission of huge amounts of SF_6 . Therefore, how to deal with SF_6 has become a hot issue in the field of environmental protection.

Scholars have done a lot of research on the treatment of low concentrations SF_6 . Methods like radio frequency plasma, microwave plasma and photolysis degradation were applied to remove it, ⁶⁻⁸ but the effective treatment concentrations of the above studies were no more than 1%. However, the concentration of SF_6 used in power industry is high. Up to now, scholars around the world are still lacking in research on high concentration SF_6 treatment.

Dielectric barrier discharge (DBD) technology has been widely used in the reduction of industrial exhaust due to its high efficiency and economy. DBD can generate reactive species in the discharge gap to physically and chemically interact with the waste gas molecules resulting in the decomposition of them. In recent years, Zhang *et al.* used DBD plasma to destruct SF₆ (2%) under static conditions. Although high destruction and removal efficiency (DRE) was obtained, there were still some problems such as low energy yield (EY) and long treatment cycle. Those obstacles inhibit the further application of DBD.

Changing gas composition has been applied to enhance the processing efficiency of DBD reactors. Lee et al. destructed SF₆ in Ar/N2/O2 system to study the effects of additional gases on DBD reduction of SF₆.13 Zhang et al. added NH₃ to the DBD reactor to promote the SF₆ destruction. The above studies show that the additional gases can significantly impact the EY of DBD treatment of SF₆. Meanwhile, some research has shown that packing materials in DBD reactors can greatly improve the EY of DBD. 15-18 Lee et al. used packed bed reactors (PBRs, DBD reactors containing packing materials) to degrade SF₆ and CF₄. ¹⁸ Both methods have a greatly influence on the EY of SF₆ abatement, but there is no report on the synergistic effect of oxygen on PBRs degradation of high concentration SF₆. If oxygen and packing materials can obtain good synergy, it will provide the possibility for PBRs to handle flowing high concentration SF_6 (2–10%). The treatment of flowing high concentration SF₆ not only can

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[†] Electronic supplementary information (ESI) available. See DOI: 10.1039/c9ra05629g

improve the processing efficiency but also can save a large amount of carrier gas, which has significant economic benefits. In addition, the effect of oxygen concentration on the products selectivity has not been studied, although the relationship between them is crucial for the waste gas treatment.

Oxygen is a commonly used oxidant. Its active O radicals in the plasma region can oxidize low fluorine sulfides, thereby promoting the degradation of SF₆, but it is also an electronegative gas, excessive oxygen in the system also has an adverse effect on destruction. 13,19,20 Therefore, there is a balance to be achieved between the reaction of O radicals with low fluorine sulfides, and the negative effect of oxygen on SF₆ degradation in PBRs. This paper aims to study the synergistic effect of different concentration of oxygen and PBRs, and to investigate the selective effect of oxygen concentration on SF₆ degradation by-products, so as to provide guidance for further treatment of SF₆.

Method

2.1. Test platform

The overall schematic and physical picture of the PBR plasma system test platform are shown in Fig. 1(a) and (b). The whole system consists of three parts: gas distribution system, discharge system and detection system.

The gas distribution system which was used to provide different mixing ratio gases required for the degradation process included a gas distribution meter (GC500, Tunkon

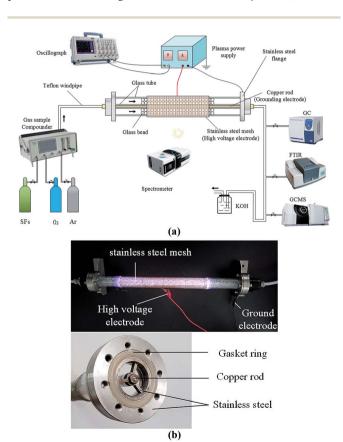


Fig. 1 (a) The schematic diagram of the PBR plasma system test platform. (b) The figure of the PBR.

Electric Technology Co., Ltd.) and a gas source (Newradar Gas Co., Ltd., Wuhan). The gas distribution meter's maximum output flow rate was 3000 mL min-1, gas distribution accuracy $\pm 1\%$ F.S., maximum dilution ratio 300 : 1. The flow rate was controlled by a gas rotameter (50-250 mL min⁻¹). The gas used in this test was 99.999% SF₆, 99.999% O₂ and 99.999% Ar.

The discharge system was used to remove SF₆, which consisted of a plasma power supply (CTP-2000 K, Nanjing Suman Electronics Co., Ltd.) and a PBR. The plasma was generated by the plasma power supply with discharge working voltage 0-30 kV, output power 0-300 W, discharge frequency 0-20 kHz; a stainless steel mesh (high-voltage electrode) was wrapped tightly around a coaxial dual dielectric quartz tube with dielectric thickness of 2 mm and an inner diameter of 20 mm. The inner ground electrode was a copper rod with an external diameter of 4 mm, installed along the axis of the quartz tube. The discharge length was about 200 mm with a discharge gap of 6 mm. The gap was filled with 3.5 mm diameter glass beads as packing materials. The packing fraction was about 0.59 and the gas gap volume of discharge area was 21.68 cm3. Fixed packing fraction was maintained throughout the test, because this parameter would affect the performance of the whole system.21

The detection system consists of a digital oscilloscope (DPO7254C, Tektronix Technology Co., Ltd.), an emission spectrometer (MX2500C, Ocean Optics Co., Ltd.), Gas Chromatograph (GC, GC-450, Shanghai Huishi Instrument), Fourier Transform Infrared Spectrophotometer (FTIR IRTracer-100, SHIMADZU Co., Ltd.) and Gas Chromatography Mass Spectrometer (GC-MS Shimadzu Ultra 2010 plus with CP-Sil 5 CB column, SHIMADZU Co., Ltd.). The digital oscilloscope (4channel 1G bandwidth, maximum real-time sampling rate 20 GS per s) was used to monitor the instantaneous discharge voltage and current in the PBR. The input power of the plasma power source was read directly from the power supply. The emission spectrometer was a three-channel one which includes three gratings (GRATING_#H5U-UV-UPGD 1200 Line Holographic, H1-H14 and HC-1). It could measure the wavelength from 300 nm to 810 nm, and its optical resolution is 0.1 nm, the integration time was 1 ms to 65 s, and the trigger delay and trigger jitter were 450 ns and 10 ns. The GC was used to detect the concentration of SF₆ in the exhaust gas (detector sensitivity was greater than 5000 mV mL mg⁻¹, using the area internal standard method). Among them, in the test, GC used 99.999% He as carrier gas, and the peak time of separation SF_6 was 2.2-2.4 min. The exhaust gas also passed through GC-MS (inlet temperature was 200 °C, injection was performed in split injection mode with a split ratio of 109:1 and inlet pressure of 56.1 kPa); column flow rate was 1.2 mL min^{-1}), 99.999% He was used as carrier gas, and internal peak integration method could be used to quantitatively detect SO₂F₂, SOF₂, SO₂, SOF₄ four kinds of decomposition gases. The remaining products were qualitatively detected by FTIR. The relevant parameters were: detection band 4000-400 cm⁻¹; fraction 1 nm; scan times 10 times; infrared detection pool optical path 10 cm. The tail gas was further treated by a KOH solution scrubber.

The test conditions are summarized as follows: the input power was fixed at 110 W, the power frequency was fixed at 8.7 kHz, Ar was used as the carrier gas to reduce the breakdown voltage of the gas mixture. All the experiments in this paper were conducted at room temperature (298 K) under atmosphere (101.3 kPa). The applied oxygen concentration was 0–8%, and the SF₆ concentration was 2–10%. All tests were carried out twice to ensure that the test results were accurate enough.

2.2. Parameter calculation method

In this paper, the DRE of SF₆ is defined as follows:

$$DRE(\%) = \frac{C_{in} - C_{out}}{C_{in}} \times 100\%$$
 (1)

where C_{in} and C_{out} refers to the concentrations (ppm, part per million) before and after the treatment.

EY is obtained based on DRE and input power, and the formula is as follows:

$$EY(g \ kW^{-1} \ h^{-1}) = \frac{m_{SF_6}}{P_{in}}$$
 (2)

where m_{SF_6} is the mass (g) of SF₆ degraded per unit time (h) and P_{in} is the input power (kW) of the plasma power source.

The selectivity equation for the main sulfur-containing products is as follows:

$$S_{\rm K} = \frac{C_{\rm K}}{C_{\rm in} - C_{\rm out}} \times 100\% \tag{3}$$

Among them, S_K is the concentration of a certain degradation product, C_{in} and C_{out} are the concentrations of SF₆ before and after the treatment.

3 Results and discussion

3.1. DRE

Shown in Fig. 2 are DREs plotted against SF_6 concentration in the presence of no oxygen, 2% O_2 and 8% O_2 . Noted that the 2% O_2 group has the highest DRE, followed by the no O_2 group and the lowest in the 8% O_2 group. When the concentration of SF_6

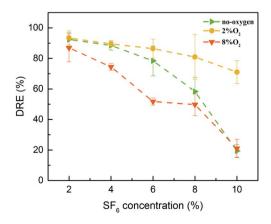


Fig. 2 $\,$ SF $_{\!6}$ DREs under different gas compositions (110 W, 150 $\,$ mL $\,$ min $^{-1}$).

was 2%, high DREs were obtained under three oxygen concentration conditions. With the increase of SF_6 concentration, all DREs decreased, but the no O_2 group and the 8% O_2 group decreased rapidly while the 2% O_2 group decreased slowly.

Based on the above test results, combined with the study of Zhang $et\ al.$, this paper summarizes the decomposition process of SF_6 into two stages. The first stage is the collision decomposition stage of SF_6 molecules, which includes the formation of micro-discharge channels, the transport of charges, and the excitation, decomposition, and ionization processes of atoms and molecules.

$$e + Ar \rightarrow e + Ar^*$$
 (4)

$$Ar^* + SF_6 \rightarrow SF_x + (6 - x)F + Ar$$
 (5)

$$SF_6 + e \rightarrow SF_x + (6 - x)F + Ar$$
 (6)

where x = 1, 2, 3, 4, 5. Ar* refers to the excited state of the argon atom. According to the eqn (4)–(6), there are two ways to decompose SF₆. One is caused by the collision of high-energy electrons with SF₆ molecules, and the other is caused by the collision of metastable argon atoms with them. When two or more particles undergo an inelastic collision, the S–F bonds in the SF₆ molecule are broken to form a low fluorine sulfide and free F radicals. These processes constitute a preliminary decomposition of the SF₆ molecules.

Additionally, Fig. 2 shows that when the concentration of SF_6 was 2%, the DREs of the no O_2 group and the 2% O_2 group were 92.50% and 93.42%, respectively; the DRE of 8% O_2 group was slightly lower, 86.93%. These results illustrate that when the concentration of SF_6 is low, the auxiliary effect of oxygen is not obvious. As the concentration of SF_6 increased, the three curves gradually decreased. When the concentration of SF_6 reached 10%, the DREs of no O_2 group and 8% O_2 group decreased significantly, which was 19.43% and 21.03%, respectively. The DRE of 2% O_2 group was much higher than that of the previous two groups, which was 71.00%. This is because SF_6 is a strong electronegative gas, and a high concentration of SF_6 gas absorbs a large amount of seed electrons (electrons before collision) thereby destroying the removal conditions, resulting in lower DREs.

$$SF_x + (6 - x)F \rightarrow SF_6 \tag{7}$$

The second stage was the recombination of low-fluorine sulfide and the reaction with O radicals. Low-fluorine sulfides were less stable than SF_6 , and they could easily combine with F radicals to form SF_6 , as shown in eqn (7). When the concentration of SF_6 was low, the recombination was not easy to occur because the concentration of SF_6 by-products in the reaction zone was also low, and the degradation process of SF_6 was much faster than the recombination process. However, as the concentration of SF_6 increased, the composite reaction of its products continued to increase. At this point, the recombination must be blocked to achieve better abatement. The addition of O_2 blocked the reaction (7), consuming a portion of the low

fluoride, such as eqn (19)-(22) and (27), thereby promoting the SF₆ decomposition.

Furthermore, Fig. 2 suggests that when the concentration of SF₆ was 6-10%, the DRE of 2% O₂ group was much higher than that of no O₂ group, because the addition of 2% O₂ consumed some low-fluorine sulfide. The recombination of SF₆ molecules was slowed down, and more SF₆ molecules were decomposed, thus obtaining a higher DRE.

Fig. 3 compared the electrical signals of the no O₂ group and the 8% O2 group. The above two figures showed that the phase of the current was ahead of the voltage. This was easy to understand, because the discharge tube was equivalent to

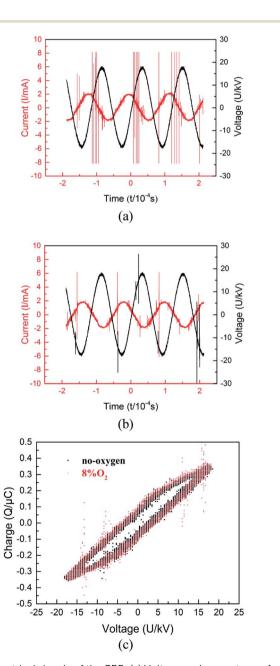


Fig. 3 Electrical signals of the PBR. (a) Voltage and current waveform of no O_2 group. (b) Voltage and current waveform of 8% O_2 group. (c) Lissajous figures of no-oxygen and 8% O₂ (6% SF₆, 110 W, 150 $mL min^{-1}$).

a coaxial capacitor, when the air gap was broken down, it could be equivalent to a parallel connection of capacitor and resistance. Moreover, the breakdown of air gap would lead to the distortion of current waveform, because this process made the electrical parameters non-linear. Furthermore, there was no obvious difference between the applied voltage amplitude, but the amplitude and shape of the current waveform were different. Firstly, the current amplitude of 8% oxygen group was slightly smaller than that of no-oxygen group. This might be due to the inhibition of oxygen on discharge, which reduced the charge transfer between electrodes in each discharge cycle. Moreover, it could be seen that the discharge pulse of the no O2 group was more than that of the 8% O2 group, and its amplitude was higher. Therefore, under the same conditions, O₂ could weaken the micro-discharge in the reaction tube (the difference in discharge pulse was not obvious when the oxygen concentration was low, so it was not given in this paper). Similar to SF₆, this might be because oxygen was also an electronegative gas, which had a good affinity for electrons, and adsorbed a part of free electrons to form negative oxygen ions,27 resulting in a decrease in free electron density in the reaction region. Accordingly, the charge density of the electrode surface was reduced, and the induced voltage generated by the electrode was also reduced, thereby causing the voltage of the gas to rise and the breakdown voltage thereof to rise accordingly. These changes were detrimental to impact ionization within the reaction tube and result in fewer S-F bonds being broken. This also explained the fact that the DRE of the 8% O₂ group in Fig. 2 was always the lowest.

Fig. 3(c) shows the Lissajous figures of SF₆ abatement at nooxygen and 8% O2 conditions. The area of the Lissajous figure represents the discharge power in a period and the slope of four edges corresponds to the equivalent capacitance, but as shown in the figure, the addition of oxygen does not change them. 22,28,29 The above phenomena illustrate that the external gas has no effect on the electrical parameters of the discharge circuit. That may be due to the difference of electric constant between oxygen, argon and sulfur hexafluoride can be neglected. Therefore, the addition of oxygen does not change the electrical parameters of PBR.

This section analyzed the effect of oxygen concentration on the DREs of SF₆. The discharge current waveform of PBRs proves that excess oxygen will affect its discharge process to hinder the decomposition of SF₆. In this context, the oxygen concentration is preferably between 0 and 4%, higher than this value is excessive. However, The DREs decreases with the SF₆ concentration in the system, the higher concentration of SF₆ was not studied in this paper, because too low DRE makes no sense to reduce emissions.

3.2. EY

In Fig. 4, the effect of oxygen concentration on EYs of the PBR degradation under different SF₆ concentrations is shown. In this paper, EYs were calculated by DREs. In order to facilitate the observation of the effect of oxygen concentration on EY,

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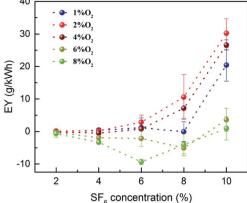


Fig. 4 Effect of different oxygen concentrations on degradation of different concentrations of SF₆ (110 W, 150 mL min $^{-1}$, the values in the figure are all after deducting the EY of corresponding no-oxygen condition).

the EY of the oxygen-containing group was subtracted one by one from the EY of the no $\rm O_2$ group. Fig. 4 demonstrates that the EY of 6% $\rm O_2$ and 8% $\rm O_2$ groups are all below the zero line, indicating that oxygen in this concentration range has a negative impact on the SF₆ degradation. Meanwhile, the line diagrams of 1%, 2%, and 4% $\rm O_2$ groups are all located above the zero line. It can be seen that $\rm O_2$ promotes the decomposition of SF₆ in this oxygen concentration range. Moreover, when the concentration of SF₆ was 6% or less, the promoting effect was not obvious, and the promoting effect was obvious when it was higher than 6%.

In this experiment, the highest EY of the no O_2 group occurred when the concentration of SF_6 was 6%, which was 25.16 g kW⁻¹ h⁻¹; the highest EY of the oxygen-containing group appeared under the condition of 10% SF_6 and 2% O_2 , which was 37.99 g kW⁻¹ h⁻¹. The maximum EY increased by 50.99%. This suggests that the addition of 2% O_2 enables the PBR to treat higher concentrations of SF_6 . Fig. 5 compares the literature, ^{13,14} and the maximum EY obtained in this paper, which shows a significant synergy between the proper amount of oxygen and the PBR.

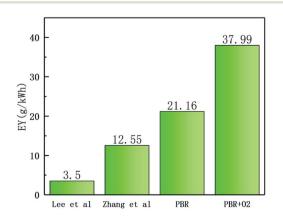


Fig. 5 EYs for different conditions from this study and Lee $et\ al.^{13}$ and Zhang $et\ al.^{14}$

The flow rate has a great influence on the degradation of SF_6 . Under the same experimental conditions, the DRE and EY of SF_6 at different flow rates were studied.

The data presented in Fig. 6 shows that as the flow rate increases, the DRE decreased from 93.90% (100 mL min $^{-1}$) to 56.86% (250 mL min $^{-1}$), and the EY increased from 21.81 g kW $^{-1}$ h $^{-1}$ (100 mL min $^{-1}$) to 33.02 g kW $^{-1}$ h $^{-1}$ (250 mL min $^{-1}$). This indicates that SF $_6$ cannot be completely degraded at high flow rates, but the amount of SF $_6$ molecules that were degraded at high flow rates was greater. Within a certain flow rate range (100–250 mL min $^{-1}$, the corresponding average residence time of the mixed gas is 17.34–5.20 s), the number of SF $_6$ molecules entering the PBR per unit time increased with the increase of flow rate, and the average residence time of each SF $_6$ molecule in the PBR was reduced, which causing a part of SF $_6$ to be discharged out of the tube without reaction, thereby reducing the DRE; but at the same time, a larger number of SF $_6$ molecules are degraded, so that the EY increased.

This section analyzed the EY of the PBR at different oxygen concentrations and flow rates, demonstrating a clear synergistic effect between oxygen and the PBR. However, the high EY obtained was accompanied by a lower DRE, which would become an obstacle to improve EY. Such a situation can be solved by secondary degradation, that is, the degraded exhaust gas is again degraded by PBRs. ^{30,31} Secondly, limited by the size of the device, the PBR used herein is suitable for the abatement of SF₆ gas with a flow rate not exceeding 150 mL min⁻¹. To handle larger flows of gas, multiple PBRs can be used in parallel, both of which are the subject of our further research.

3.3. By-products analysis

3.3.1. Emission spectrum analysis. Fig. 7(a) and (b) show the emission spectra of the $SF_6/O_2/Ar$ plasma, and the characteristic lines in them correspond to several reactive species. Compared with the NIST database, ³² the $SF_6/O_2/Ar$ plasma emission was initially diagnosed. Due to the large difference in the proportion of different elements in the $SF_6/O_2/Ar$ system, the intensity difference of the emission spectrum is also large.

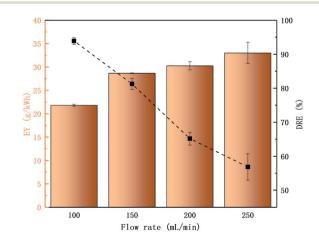


Fig. 6 EY and DRE under different flow rates (6% SF₆/2% O₂/Ar, 110 W).

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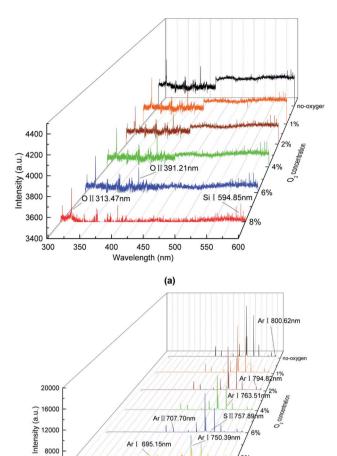


Fig. 7 The emission spectra of the PBR (6% SF₆, 110 W). (a) 300-600 nm (b) 600-810 nm.

(b)

620 640 660 680 700 720 740 760 780 800

Wavelength (nm)

Ar I 738.40nm

In order to show the characteristic lines more clearly, the emission spectrum was divided into two sections (300-600 nm (a) and 600-810 nm (b)). Fig. 7(a) shows there is an element detected (Si I 594.85 nm). The intensity of the segment line was low, indicating that the amount of corresponding material was also small. The presence of the Si element indicates that the products of SF₆ reacts with the glass wall and the glass tube (etching effect). The purpose of using glass tubes and beads in this paper is to detect the emission spectra better. Meanwhile, glass beads as packing materials can enhance the electric field in the tube.18

Fig. 7(b) shows the other two elements detected (Ar I 695.15 nm, Ar I 750.39 nm, nm, Ar I 763.51 nm, Ar I 794.82 nm, Ar I 800.62 nm). Compared with other elements, Ar has the highest line emission intensity because argon has the highest proportion of the whole system, reaching over 86%. These lines show that a large amount of argon atoms were excited. When the energy of electrons exceeds 11.5 eV, argon atoms can be excited. Calculations show that, under this condition, the energy of most of the free electrons in the system can exceed

this value, so a large number of argon atoms were excited.11 Eqn (4) shows the process. In addition, due to the environment noise and the spectrometer error, some spectral lines can not be well diagnosed. We also made a possible analysis of it. Those lines may include O II 313.57 nm, O II 391.51 nm, S II 757.89 and Ar II 707.70 nm. The argon lines have been analyzed previously. In addition, the existence of O radicals may be due to the involvement of oxygen or tube wall (SiO₂) in the reaction. Furtherly, the S radicals may be as a result of SF₆ molecules decomposition.

Furthermore, Fig. 7(b) shows the intensity of Ar lines decrease with the oxygen concentration. Because the emission line intensity of the spectral line is proportional to the population density of the excited state involved in the optical emission. Under the local thermal equilibrium condition (LTE), the electron temperature was measured by using the wellknown Boltzmann plot:33

$$kT_{\rm e} = (E_2 - E_1) \ln \left[\frac{I_1 \lambda_1 g_2 A_2}{I_2 \lambda_2 g_1 A_1} \right]^{-1}$$
 (8)

where the indices 1 and 2 are the first and second spectral lines, k is the Boltzmann constant, I is the measured intensity of the spectral lines, E is the energy of the excited states, g is the statistical weight and A is the transition probability. Two Ar-I lines were selected for determination of the electron temperature. These lines were resulted from the 4p¹ to 4s[0] transition at 794.82 nm and $4p^2$ to $4s^1$ at 800.62 nm and the details are collected in Table 1. The intensities of these Ar-I lines were obtained from the spectrum by integrating over the line profile and normalizing with the spectral response of the sensitivity of the instrument. The electron temperature for different oxygen concentration was obtained by repeating the same procedure.

Fig. 8 shows a decreasing trend in the electron temperature with rise of oxygen concentration. Such descending trend in electron temperature may be due to the decline of electrons kinetic energy in the discharge plasma. For atmospheric pressure PBRs, although the mean free path of the electrons within the discharge remains constant, due to an increase in oxygen concentration, electrons are increasingly affected by the adsorption of oxygen molecules, which eventually leads to less and less energetic electrons are available for plasma chemical reaction. Therefore, the oxygen molecules suppress the excitation and ionizing of the neutral plasma species and consequently the electron temperature.

3.3.2. FTIR analysis. In Fig. 9, SF₆ degradation by-products were detected by FTIR. The peak information is mainly referred to the research by Kurte and Zhang et al. 19,34 In the SF₆/O₂/Ar system, the decomposition products of SF₆ are SO₂F₂, SiF₄, SOF₂, SOF₄, SF₄, SO₂, and OF₂. This is similar to the conclusion

Table 1 The data of spectral lines $E (cm^{-1})$ Lines $\lambda (nm)$ g Ref. [NIST]³² 3 Ar-I 794.82 1.86×10^{7} 107 131.71 $[\text{NIST}]^{32}$ Ar-I 800.62 4.90×10^{6} 106 237.55 5

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0.10
0.18
0.16
0.12
0.10
0 1 2 4 6 8
0.10
0.10
0 2 concentration (%)

Fig. 8 The electron temperature as a function of oxyger concentration.

of Lee *et al.* Among them, SO_2F_2 and SiF_4 are the main products, which may be because the two materials are relatively stable, and the presence of SiF_4 once again proves the existence of etching effect. By ref. 19, it can be noted that in addition to the above by-products, there should be S_2F_{10} , but it is not recognized in the FTIR diagram, probably because the substance is easily decomposed as shown in eqn (28), or it overlaps with the peaks of SO_2F_2 , which leads to the failure of diagnosis.

3.3.3. GCMS analysis. Fig. 10 shows the content of sulfurcontaining degradation products measured by GCMS (products include but are not limited to the four substances and the relevant formulas are provided in the Appendix).

Firstly, the concentration of SO_2F_2 was the lowest at 12 444.67 parts per million (ppm) under no O_2 conditions. As the oxygen concentration reached 4%, the concentration of SO_2F_2 reached a maximum of 22 385.36 ppm. This may be because the O radicals in the system were capable of oxidizing SOF_2 , SOF_4 and SF_X to SO_2F_2 , as shown in eqn (23) and (24). Therefore, as the oxygen concentration boosted, the concentration of SO_2F_2 also increased. However, as the oxygen concentration further increased, its concentration began to decrease. When the oxygen concentration was 8%, its concentration was only 17 873.33 ppm. This might be because as the oxygen became excessive, the EY of the system decreased. As shown in Fig. 4, the amount of handled SF_6 molecules was correspondingly reduced, eventually resulting in a decrease in products concentration, which contributed to the decrease of SO_2F_2 .

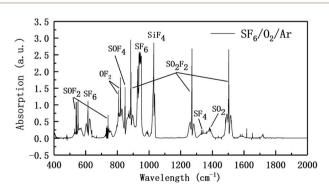


Fig. 9 FTIR spectrum of by-products (6% SF₆/2% O₂/Ar).

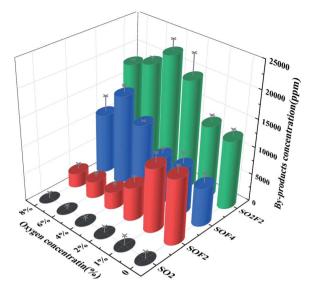


Fig. 10 Four SF₆ degradation products concentration (6% SF₆/Ar).

Under the no O_2 environment, the concentration of SOF_2 was the highest, which was 11 820.21 ppm. With the increase of oxygen concentration, the concentration continued to decrease. When the oxygen concentration reached 8%, the concentration of SOF_2 was only 2538.07 ppm. This indicated that oxygen has an inhibitory effect on the formation of SOF_2 . It was known from the

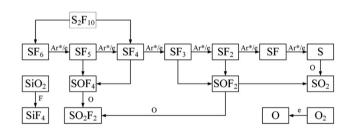


Fig. 11 SF₆ degradation path.

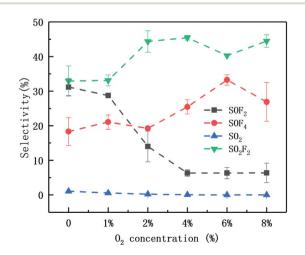


Fig. 12 Selectivity of four products under different oxygen concentrations (6% $\rm SF_6$, 110 W, 150 mL $\rm min^{-1}$).

Table 2 Physicochemical properties of several major degradation products¹⁴

Product	Melting point (°C)	Boiling point (°C)	Chemical properties
SO_2F_2	-124.7	-55.4	Slow hydrolysis in lye
SOF_2	-130	-43.8	Hydrolysis produces HF (reacts with lye) and SO ₂
SO_2	-72.7	-10	Reaction with lye
SF_4	-99.6	-49.0	Hydrolysis produces SOF ₄
SOF_4	-120	-55.4	Hydrolysis produces SO ₂ F ₂ and HF
S_2F_{10}	-55	29	Easily decomposed into SF ₆ and SF ₄
SiF ₄	-90	-86	Easy to react with alkali to form silicate

egn (21), (22) and (24), Table 3 that SOF₂ was mainly formed by reacting a low fluorine sulfide with an O radical, and it could further react with an O radical to form SO₂F₂. Probably because the secondary oxidation process was faster than the primary oxidation. Therefore, under no O₂ condition, the concentration of O radicals in the system was lower, and more SOF₂ was generated; as the oxygen concentration increased, more and more SOF₂ was further oxidized to form SO₂F₂, and meanwhile, the concentration of SOF2 would decrease further as the EY decreased.

The concentration of SOF₄ slowly increased with increasing oxygen concentration, reaching a maximum value of 15 975.24 ppm at an oxygen concentration of 6%, and then decreased. From eqn (19)-(20), both SF₄ and SF₅ could generate SOF₄ with O radicals. Meanwhile, it was known from the eqn (23) that the substance can be further oxidized to form SO₂F₂. Therefore, as the oxygen concentration increased, more and more low-fluorine sulfides were oxidized to form SOF₄, but at the same time, some SOF₄ was further oxidized. Consequently, overall showing a slow increase in SOF₄ concentration. When the oxygen concentration was excessive, the low EY of the system also leaded to a decrease in the concentration of SOF₄.

The concentration of SO₂ decreased with the increase of oxygen concentration, refer to the reaction eqn (25) and (26). It could be observed that the reaction to generate SO₂ was not much, and eqn (25) was the easiest to occur, but at the same time, it was known from eqn (13)-(18) that S radicals are extremely low in the system because only the six S-F bonds of SF₆ broken could it generate a S radical. Eqn (26) should be the main generation path of SO2, but as the reactant SOF₂ decreased sharply, the SO₂ generated by the path also decreases rapidly. The degradation path of SF₆ was in Fig. 11.

Fig. 12 shows the selectivity of four products as a function of oxygen concentration during 6% SF₆ gas degradation. The selectivity of SO₂F₂ is always the highest, ranging from 32.93% to 45.43%, because the substance has the highest stability and is the final product of SF₆ (as shown in the Fig. 11). The selectivity of SO2 is always low, close to zero, and has been analyzed from its source. The selectivity of SOF₂ and SOF₄ changed greatly with the increase of oxygen concentration. When the oxygen concentration is less than 2%, the selectivity of SOF₂ is greater than SOF₄, otherwise, SOF₄ is more selective. This may be because when the oxygen concentration is

low, the source of O radicals in the system is mainly SiO₂. As shown in eqn (29), SiO₂ can react with four F radicals to form SiF₄ and two O radicals. As the oxygen concentration increases, the concentration of O radicals in the system increases, which undoubtedly inhibits the participation of SiO₂, causing the content of SiF₄ in the product is relatively reduced, while one SOF₄ molecule is capable of immobilizing 4 F atoms. Therefore, SOF₄ is more selective at higher oxygen concentrations

Table 2 lists the physicochemical properties of several major products. SO₂F₂, SOF₂, SO₂, SF₄, SOF₄ can react with lye (KOH) to form KF and K₂SO₄, which effectively prevents the products from recombination and can also achieve the further processing of products.35

In this part, the reactive species, electron temperature and products in the degradation process of SF₆ were analyzed by emission spectrometer, FTIR and GCMS, and the decomposition path of SF₆ in oxygen-containing environment was summarized. The concentration variation and selectivity of four products at different oxygen concentrations were discussed, demonstrating that oxygen participates in the second stage of the SF₆ degradation process, that was, the process of combining low-fluoride sulfide with reactive species such as O to form secondary degradation products to affect the decomposition of SF₆. The by-products also confirmed that the concentration of the applied gas can also affect the selectivity of the products.

Conclusion 4.

In this paper, the degradation of high concentration SF₆ by the PBR was carried out at different oxygen concentrations. The synergistic effect of oxygen and the PBR on SF₆ degradation was investigated.

The results show that an appropriate amount of oxygen in the system can greatly improve the EY of SF₆ degradation in the PBR. The highest EY can be obtained when the concentration of SF₆ is 10%, which is 37.99 g kW⁻¹ h⁻¹ under the condition of 2% O2. However, when the oxygen in the system is excessive, the degradation effect will be worse than that of the no O2 group. Moreover, the current waveform of PBR also demonstrates that 8% O2 has a weakening effect on the microdischarge. From the perspective of EY, oxygen concentration within 4% promotes degradation, above which it hinders

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degradation. Meanwhile, the flow rate can significantly affect the degradation efficiency. In the flow rate range of this paper, the DRE decreases with the increase of the flow rate, and the EY increases with the increase of the flow rate. Furthermore, the exist of active radicals such as Ar and Si suggests the exciting process in the PBR. The intensity of the emission spectra and electron temperature reveal the fact that the addition of oxygen will suppress the collision in the system and weaken the degradation effect. In addition, the products obtained herein mainly include SO₂F₂, SiF₄, SOF₂, SOF₄, SF₄, SO₂ and so on. Among the four degradation products (SO₂F₂, SOF₂, SOF₄, SO₂) of SF₆ under all conditions, the highest selectivity is SO₂F₂, and the lowest selectivity is SO₂. The concentration and selectivity of SOF2 and SOF4 are related to the oxygen concentration. When the oxygen concentration does not exceed 2%, the SOF2 selectivity is higher than SOF4 in the degradation process of 6% SF₆. Conversely, SOF₄ selectivity is higher than SOF₂.

It is proved that the EY can be improved and the product selection could be adjusted by controlling the oxygen concentration in the PBR plasma system. This paper provided experimental support for further engineering application of SF₆ exhaust gas treatment and better understanding of the effect of oxygen concentration has on the SF₆ degradation in

Appendix

Table 3 Reaction formula and reaction heat of SF₆ degradation

No	Reaction	Reaction heat (kcal mol ⁻¹)
(9)	$e^* + O_2 \rightarrow O + O + e$	112.51
(10)	$e^* + O_2 \rightarrow O + O^-$	90.57
(11)	$e^* + O_2 \rightarrow O^+ + O + 2e$	324.53
(12)	$O^- \rightarrow O + e$	21.05
(13)	$SF_6 \rightarrow F + SF_5$	86.09
(14)	$SF_5 \rightarrow F + SF_4$	41.46
(15)	$SF_4 \rightarrow F + SF_3$	97.15
(16)	$SF_3 \rightarrow F + SF_2$	53.32
(17)	$SF_2 \rightarrow F + SF$	86.18
(18)	$SF \rightarrow F + S$	113.79
(19)	$SF_5 + O \rightarrow SOF_4 + F$	-42.53
(20)	$SF_4 + O \rightarrow SOF_4$	-126.63
(21)	$SF_3 + O \rightarrow SOF_2 + F$	-77.57
(22)	$SF_2 + O \rightarrow SOF_2$	-130.89
(23)	$SOF_4 + O \rightarrow SO_2F_2 + 2F$	-87.39
(24)	$SOF_2 + O \rightarrow SO_2F_2$	-39.03
(25)	$S + 2O \rightarrow SO_2$	-274.71
(26)	$SOF_2 + O \rightarrow SO_2 + 2F$	-68.33
(27)	$2F + O \rightarrow OF_2$	_
(28)	$S_2F_{10} \rightarrow SF_4 + SF_6$	_
(29)	$SiO_2 + 4F \rightarrow SiF_4 + 2O$	_

Conflicts of interest

There are no conflicts to declare.

Acknowledgements

This work was supported by the National Natural Science Foundation of China (NSFC, under Grant 51777144) and State Grid Science and Technology Project (SGHB0000KXJS1800554).

References

- 1 J. Reilly, et al., Multi-gas assessment of the Kyoto protocol, Nature, 1999, 401(6753), 549-555.
- 2 Y. Li, X. Zhang, S. Tian, S. Xiao, Y. Li and D. Chen, Insight into the decomposition mechanism of C₆F₁₂O-CO₂ gas mixture, Chem. Eng. J., 2019, 360, 929-940.
- 3 Y. Li, X. Zhang, J. Zhang, S. Xiao, B. Xie, D. Chen, Y. Gao and J. Tang, Assessment on the toxicity and application risk of C₄F₇N: a new SF₆ alternative gas, J. Hazard. Mater., 2019, 368, 653-660.
- 4 Y. Li, X. Zhang, J. Zhang, X. Cheng, X. Shao, Z. Wang, D. Chen and X. Song, Study on the thermal decomposition characteristics of C₄F₇N-CO₂ mixture as eco-friendly gas insulating medium, High Voltage, DOI: 10.1049/high voltage.2019.0032.
- 5 M. Rabie and C. M. Franck, Assessment of eco-friendly gases for elec-trical insulation to replace the most potent industrial greenhouse gas SF₆, Environ. Sci. Technol., 2018, 52(2), 369-380.
- 6 M. Shih, W.-J. Lee and C.-Y. Chen, Decomposition of SF₆ and H₂S Mixture in Radio Frequency Plasma Environment, Ind. Eng. Chem. Res., 2003, 42, 2906-2912.
- 7 C.-H. Tsai and J.-M. Shao, Formation of fluorine for abating sulfur hexafluoride in an atmospheric-pressure plasma environment, J. Hazard. Mater., 2008, 157, 201-206.
- 8 X. Song, X. Liu, Z. Ye, J. He, R. Zhang and H. Hou, Photodegradation of SF₆ on polyisoprene surface: implication on elimination of toxic byproducts, J. Hazard. Mater., 2009, 168, 493-500.
- 9 X. Wang, Dielectric Barrier Discharge and Its Application, High Voltage, 2009, 35(1), 1-11.
- 10 T. Shao, Z. Cheng, W. Ruixue, et al., Atmospheric-pressure pulsed gas discharge and pulsed plasma application, High Voltage., 2016, 42(3), 685-706.
- 11 X. Zhang, H. Xiao and X. Hu, Effects of Reduced Electric Field on Sulfur Hexafluoride Removal for a Double Dielectric Barrier Discharge Reactor, IEEE Trans. Plasma Sci., 2018, 46(3), 563-570.
- 12 X. Zhang, H. Xiao, J. Tang, et al., Recent advances in decomposition of the most potent greenhouse gas SF₆, Crit. Rev. Environ. Sci. Technol., 2017, 47(18), 1763-1782.
- 13 H. M. Lee, M. B. Chang and K. Y. Wu, Abatement of sulfur hexafluoride emissions from the manufacturing process by atmospheric pressure plasmas, J. Air Waste Manage. Assoc., 2004, 54(8), 960-970.

14 X. Zhang, Z. Cui, Y. Li, *et al.*, Abatement of SF₆ in the presence of NH₃ by dielectric barrier discharge plasma, *J. Hazard. Mater.*, 2018, **360**, 341–348.

- 15 H. L. Chen, H. M. Lee, S. H. Chen and M. B. Chang, Review of Packed-Bed Plasma Reactor for Ozone Generation and Air Pollution Control, *Ind. Eng. Chem. Res.*, 2008, 47, 2122–2130.
- 16 C. L. Chang and T. S. Lin, Decomposition of Toluene and Acetone in Packed Dielectric Barrier Discharge Reactors, *Plasma Chem. Plasma Process.*, 2005, 25(3), 227–243.
- 17 H. H. Kim, H. Kobara, A. Ogata and S. Futamura, Comparative Assessment of Different Non-thermal Plasma Reactors on Energy Efficiency and Aerosol Formation from the Decomposition of Gas-Phase Benzene, *IEEE Trans. Ind. Appl.*, 2005, **41**(1), 206–214.
- 18 H. L. Chen, H.-M. Lee, L. Cheng, M. B. Chang, S. J. Yu and S. Li, Influence of Nonthermal Plasma Reactor Type on CF₄ and SF₆ Abatements, *IEEE Trans. Plasma Sci.*, 2008, 36(2), 509–516.
- 19 X. Zhang, Z. Cui, Y. LI, H. Xiao, L. Yi and J. Tang, Study on Degradation of SF₆ in the Presence of H₂O and O₂ Using Dielectric Barrier Discharge, *IEEE Access*, 2018, **6**, 72748–72756.
- 20 Y. S. Mok and D.-H. Kim, Decomposition of Sulfur Hexafluoride by Using a Nonthermal Plasma-assisted Catalytic Process, *J. Korean Phys. Soc.*, 2011, **59**(61), 34–37.
- 21 M. Y. Naz and S. A. Sulaiman, PTV profiling of particles motion from the top and side of a swirling fluidized bed, *J. Instrum.*, 2016, 11(5), P05019–P05036.
- 22 X. Zhang, X. Hu, Z. Cui, *et al.*, Experimental study on the effect of different background gases on the degradation of SF₆ gas by dielectric barrier discharge, *J. Electrical. Eng. Technol.*, 2018, **38**(3), 937–946.
- 23 H. Xiao, X. Zhang, X. Hu, *et al.*, Experimental and simulation analysis on by-products of treatment of SF₆ using dielectric barrier discharge, *IEEE Trans. Dielectr. Electr. Insul.*, 2017, 24(3), 1617–1624.
- 24 X. Zhang, W. Yao, J. Tang, *et al.*, Current Status and Development of Gas Fraction Analysis of SF₆ Discharge Decomposition, *High Voltage*, 2008, **34**(4), 664–747.

- 25 J. Tang, F. Liu, Q. Meng, et al., Partial Discharge Recognition through an Analysis of SF₆ Decomposition Products Part 2: Feature Extraction and Decision Tree-based Pattern Recognition, IEEE Trans. Dielectr. Electr. Insul., 2012, 19(1), 37–44.
- 26 D. Chen, X. Zhang, H. Xiong, Y. Li, J. Tang, S. Xiao and D. Zhang, A first-principles study of the SF₆ decomposed products adsorbed over defective WS₂ monolayer as promising gas sensing device, *IEEE Trans. Device Mater. Reliab.*, 2019, 19(3), 473–483.
- 27 H. Xiao, *Study on atmospheric pressure dielectric barrier discharge and its synergistic catalytic degradation of SF*₆ gas, Ph.D thesis, Chongqing University, 2018.
- 28 T. Butterworth, R. Elder and R. Allen, Effects of particle size on CO₂ reduction and discharge characteristics in a packed bed plasma reactor, *Chem. Eng. J.*, 2016, 293, 55–67.
- 29 D. Mei, X. Zhu, Y.-L. He, D. Y. Joseph and X. Tu, Plasmaassisted conversion of CO₂ in a dielectric barrier discharge reactor: understanding the effect of packing materials, *Plasma Sources Sci. Technol.*, 2015, **24**, 015011.
- 30 H. M. Lee, M. B. Chang and R. F. Lu, Abatement of Perfluorocompounds by Tandem Packed-Bed Plasmas for Semiconductor Manufacturing Processes, *Ind. Eng. Chem. Res.*, 2005, 44, 5526–5534.
- 31 K. R. Ryan and I. C. Plumb, Gas-phase combination reactions of SF₄ and SF₅ with F in plasmas of SF₆, *Plasma Chem. Plasma Process.*, 1988, **8**(3), 281–291.
- 32 NIST Atomic Spectra Database Lines Data, [on line], https://physics.nist.gov/cgibin/ASD.
- 33 M. Y. Naz, S. Shukrullah, A. Ghaffar, N. U. Rehman and M. Sagir, A Low-Frequency Dielectric Barrier Discharge System Design for Textile Treatment, *Synth. React. Inorg.*, *Met.-Org.*, *Nano-Met. Chem.*, 2016, **46**(1), 104–109.
- 34 R. K. C. Beyer and H. M. H. D. Klockow, Application of infrared spectroscopy to monitoring gas insulated high-voltage equipment: electrode material-dependent SF₆ decomposition, *Anal. Bioanal. Chem.*, 2002, 373, 639–646.
- 35 J. Wang, Decomposition gas and treatment of sulfur hexafluoride, *Chem. Propellants Polym. Mater.*, 2003, 1(6), 16–18.